

2.125Gb/s Dual Speed, 20-Bit Transceiver

Features

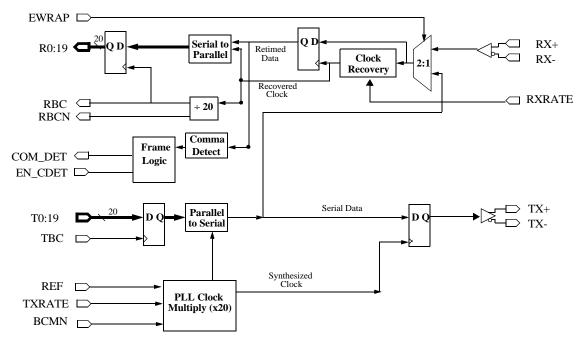
- Speed Selectable Full-Duplex Transceiver:
 1.06/2.12Gb/s for 1x 2x Fibre Channel
- 20-Bit TTL Interface for Transmit and Receive Data at 106.25MHz
- Monolithic Clock Synthesis and Clock Recovery - No External Components
- 106.25MHz TTL Reference Clock
- Automatic Lock-to-Reference Function

- Suitable for Both Coaxial and Optical Link Applications
- Low Power Operation: 2.5W max
- 80-Pin, 14mm Thermally-Enhanced EDQUAD Package
- Single +3.3V Supply

General Description

The VSC7146RH-21 is a 2.125Gb/s Transceiver optimized for ease-of-use and efficiency in high-performance data transmission systems. The VSC7146RH-21 accepts two 10-bit 8b/10b encoded transmit characters, latches them on the rising edge of Transmit Byte Clock (TBC) and serializes the data onto the TX+/- differential outputs at a baud rate, which is 20 times the TBC frequency. The VSC7146RH-21 also samples serial receive data on the RX+/- differential inputs, recovers the clock and data, deserializes it onto two 10-bit receive characters, outputs a recovered clocks at one-twentieth of the incoming baud rate and detects Fibre Channel "comma" characters. The VSC7146RH-21 contains on-chip Phase-Lock Loop (PLL) circuitry for synthesis of the baud-rate transmit clock, and extraction of the clock from the received serial stream. These circuits are fully monolithic and require no external components.

Block Diagram





2.125Gb/s Dual Speed, 20-Bit Transceiver

Functional Description

Clock Synthesizer

The VSC7146RH-21 clock synthesizer multiplies the 106.25MHz reference frequency provided on the REF input by 20 to achieve a baud rate clock at 2.125GHz. The clock synthesizer contains a fully monolithic PLL which requires no external components. An additional 106.25MHz clock, TBC, should be provided to clock in the data bus. Since TBC is only used for the purpose of clocking data in, it is not required to have the same jitter constraints as REF. REF clock and TBC should preserve certain phase margins and be of the same frequency.

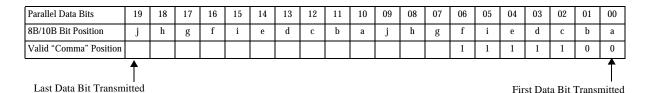
Serializer

The VSC7146RH-21 accepts TTL input data as two parallel 10-bit characters on the T[0:19] bus which is latched into the input latch on the rising edge of a 106.25MHz clock at TBC. This data will be serialized and transmitted on the TX differential outputs at a baud rate of 20 times the frequency of the TBC input, with bit T0 transmitted first. User data should be encoded for transmission using the 8B/10B block code described in the Fibre Channel specification, or an equivalent, edge rich, DC-balanced code. If EWRAP is HIGH, the transmitter will be disabled with TX+ HIGH and TX- LOW. If EWRAP is LOW, the transmitter outputs serialized data. The phases of REF clock and TBC can be identical, but there a phase relationship between the two input clocks which must be maintained.

Transmission Character Interface

In Fibre Channel, an encoded byte is 10 bits and is referred to as a transmission character. The 20-bit interface on the VSC7146RH-21 corresponds to two transmission characters. This mapping is shown in Figure 1.

Figure 1: Transmission Order and Mapping to Fibre Channel Character



Clock Recovery

The VSC7146RH-21 accepts differential high-speed serial inputs on the RX+/RX- pins, (when EWRAP is LOW), extracts the clock and retimes the data. The serial bit stream should be encoded so as to provide DC balance and limited run length by a Fibre Channel-compatible 8B/10B transmitter or equivalent. The VSC7146RH-21 clock recovery circuitry is completely monolithic and requires no external components. For proper operation, the baud rate of the data stream to be recovered should be within 200ppm of twenty times the REF frequency. This allows oscillators on either end of the link to be 106.25MHz +/- 100ppm.



2.125Gb/s Dual Speed, 20-Bit Transceiver

Deserializer

The retimed serial bit stream is converted into two 10-bit parallel output characters. The VSC7146RH-21 provides a TTL recovered clock, RBC, at one twentieth of the serial baud rate. The clock is generated by dividing down the high-speed clock which is phase-locked to the serial data. The serial data is retimed by the internal high-speed clock, and deserialized. The resulting parallel data will be captured by the adjoining protocol logic on the rising edge of RBC.

If serial input data is not present, or does not meet the required baud rate, the VSC7146RH-21 will continue to produce a recovered clock and RBC will automatically lock to the REF reference clock. This eliminates the need for a Lock-to-Reference input pin and simplifies the support software for that function.

Word Alignment

The VSC7146RH-21 provides 7-bit Fibre Channel "comma" character recognition and data word alignment. Word synchronization is enabled by asserting EN_CDET HIGH. When synchronization is enabled, the VSC7146RH-21 constantly examines the serial data for the presence of the Fibre Channel "comma" character. This pattern is "0011111XXX", where the leading zero corresponds to the first bit received. The "comma" sequence is not contained in any normal 8B/10B coded data character or pair of adjacent characters. It occurs only within special characters, known as K28.1, K28.5 and K28.7, which are defined specifically for synchronization in Fibre Channel systems. Improper alignment of the "comma" character is defined as either of the following conditions:

- 1) The "comma" is not aligned within the 10-bit transmission character such that T0...T6 = "0011111."
- 2) The "comma" straddles the boundary between two 10-bit transmission characters.

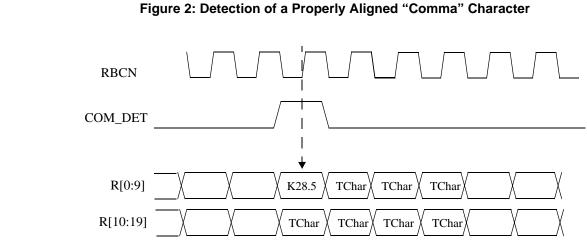
When EN_CDET is HIGH and an improperly aligned "comma" is encountered, the internal data is shifted in such a manner that the "comma" character is aligned properly in R[0:6] as shown in Figure 1. This results in proper character and word alignment. When the parallel data alignment changes in response to a improperly aligned "comma" pattern, some data which would have been presented on the parallel output port may be lost. However, the synchronization character and subsequent data will be output correctly and properly aligned. When EN_CDET is LOW, the current alignment of the serial data is maintained indefinitely, regardless of data pattern.

On encountering a "comma" character, COM_DET is driven HIGH to inform the user that realignment of the parallel data field may have occurred. The COM_DET pulse is presented simultaneously with the "comma" character and has a duration equal to the data. The COM_DET signal is timed such that it can be captured by the adjoining protocol logic on the rising edge of RBC. Functional waveforms for synchronization are shown in Figure 2 and Figure 3. Figure 2 shows the case when a "comma" character is detected and no phase adjustment is necessary. It illustrates the position of the COM_DET pulse in relation to the "comma" character on R[0:6]. Figure 3 shows the case where the K28.5 is detected, but it is out-of-phase and a change in the output data alignment is required. Note that up to three characters prior to the "comma" character may be corrupted by the realignment process.





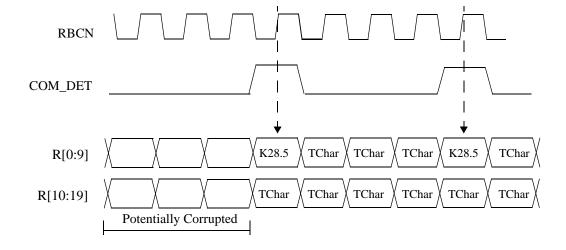
2.125Gb/s Dual Speed, 20-Bit Transceiver



TChar: 10 bit Transmission Character

Figure 3: Detection and Resynchronization of an Improperly Aligned "Comma" Character

Receiving Two Consecutive K28.5+TChar Transmission Words





2.125Gb/s Dual Speed, 20-Bit Transceiver

Dual Data Rate Operation

The VSC7146RH-21 performs at two data rates, full-speed (2.125Gb/s on the serial link, 106.25MHz on the parallel 20-bit data bus) and half-speed (106.25Gb/s on the serial link, 53.125Mb/s on the parallel 20-bit data bus). To accommodate for this, the user is provided with 3 signal pins for data rate control: TXRATE, RXRATE and BCMN. The usage of these signals is as follows:

If BCMN = 0 (Backwards Compatibility Mode), TXRATE controls both the serializer and deserializer speeds. TXRATE should be HIGH for full-speed operation and LOW for half-speed operation.

If BCMN = 1, TXRATE controls the serializer speed and RXRATE controls the deserializer speed. TXRATE and/or RXRATE must be HIGH for full-speed operation and/or LOW for half-speed operation.

Table 1: Data Rate

BCMN	TXRate	RXRate	Description	
0	1	X	Both serializer and deserializer run at full-speed.	
0	0	X	Both serializer and deserializer run at half-speed.	
1	0	0	Both serializer and deserializer run at half-speed.	
1	0	1	Serializer is run at half-speed and deserializer is run at full-speed.	
1	1	0	Serializer is run at full-speed and deserializer is run at half-speed.	
1	1	1	Both serializer and deserializer run at full-speed.	

For "comma" character (K28.5) detection, it is recommended not to use differing RXRATE inputs to actual RX rate data reception, as shown in the Table 2 (assumes $EN_CDET = 1$):

Table 2: Comma Detect

RX Rate	RX+/- Actual Data Rate	"Comma" Detect
0 Half-Speed	2.125Gb/s	Will only detect 00/00/11/11/11/11/11 pattern as "comma". Do not use .
0 Half-Speed	1.0625Gb/s	Normal detection operation.
1 Full-Speed	2.125Gb/s	Normal detection operation.
1 Full-Speed	1.0625Gb/s	Will detect false characters (e.g., those that include "0111") as "comma". Do not use .

Similarly, it is recommended not to use differing TXRATE inputs to actual TX rate data reception. The T[19:0] data bus, TBC and REF clock inputs must be at 106.25Mb/s rates if TXRATE = 1 and 53.125Mb/s if TXRATE = 0. It is important to note that the PLL will not lock otherwise.

Along with the 20-bit data input to the serializer, the user will also have to send the appropriate transmit byte clock signal (TBC)—that is, 106.25MHz when TXRATE = 1 and 53.125MHz when TXRATE = 0. REF and TBC should be frequency-locked in all cases and should maintain a certain phase relationship as shown in Figure 6. The output recovered clocks (RBC/RBCN), the output deserialized data (R[19:0]) and the internal VCO high-speed clock multiplier will be automatically adjusted by the TXRATE and RXRATE signals.

The baud rate of the data stream to be recovered in the descrializer should be within 200ppm of the REF frequency. In other words: $|F_{REF-TX} - F_{REF-RX}| \le 200 ppm$



2.125Gb/s Dual Speed, 20-Bit Transceiver

TBC

T[0:19]
20-Bit Data

Table T1

Data Valid

Data Valid

Data Valid

Data Valid

Figure 4: Transmit Timing Waveforms

Table 3: Transmit AC Characteristics

Parameters	Description	Min	Тур	Max	Units	Conditions
T ₁	T[0:19] setup time to the rising edge of TBC	1.5		_	ns	Measured between the valid data level of T[0:19] to the 1.4V point of TBC.
T ₂	T[0:19] hold time after the rising edge of TBC	1.0		_	ns	
T _{SDR} ,T _{SDF}	TX+/TX- rise and fall time	_		160	ps	20% to 80% into 50Ω load to $$V_{SS}$.$ Tested on a sample basis.
T_{LAT}	Latency from rising edge of TBC to T0 appearing on TX+ TX-			45 bc +1ns	Bit Clock	Bit clock periods (PLL locked)
Transmitter	Output Jitter Allocation					
T_{RJ}	Serial data output random jitter (RMS)	_	5	7.5	ps	RMS, tested on a sample basis.
T_{DJ}	Serial data output deterministic jitter (p-p)	_	25	30	ps	Peak-to-peak, tested on a sample basis.



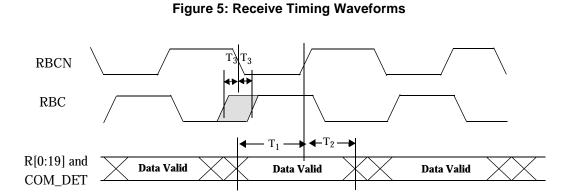


Table 4: Receive AC Characteristics

Paramete rs	Description	Min.	Max.	Units	Conditions
T ₁	Data or COM_DET valid prior to RBCN rise	1.0 2.0	_	ns	Measured between the 1.4V point of RBCN and a valid level of R[0:19] or
T ₂	Data or COM_DET valid after RBCN rise	5.0 10.0	_	ns	COM_DET. All outputs driving 10pF load. The spec on top relects RXMODE=1 and the bottom one reflects RXMODE=0.
T_3	Time difference between RBC and RBCN edges	_	1	ns	
T _{R1} , T _{F1}	RBC/RBCN rise and fall time	0.6	2.0	ns	Between $V_{IL}(\text{max})$ and $V_{IH}(\text{min})$, into 10pF load.
T _{R2} , T _{F2}	R[0:19], COM_DET rise and fall time	0.7	2.4	ns	Between $V_{IL}(max)$ and $V_{IH}(min)$, into 10pF load.
R _{LAT}	Latency from RX to R[0:19]	36bc+ 2ns	56bc+ 2ns	Bit Clocks	When locked to valid data.
T _{RBC}	RBC period	8.2 16.4	10.6 21.2	ns	The spec on top relects RXMODE=1 and the bottom one reflects RXMODE=0.
DC	RBC duty cycle	40%	60%	period	
T _{LOCK}	Data acquisition lock time @ 2.125Gb/s	_	1250	Bit Clocks	Tested on a sample basis. 95% probability of lock.



Table 5: TBC and REF Requirements

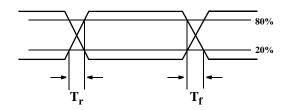
Parameters	Description	Min	Max	Units	Conditions	
T ₁	Necessary lag time between TBC and REF		2.0	ns	Measured from falling edge of REF to rising edge of TBC.	
T ₂	Necessary lead time between TBC and REF	_	2.0	ns	Measured from falling edge of REF to rising edge of TBC.	
FR	Frequency Range	105 52.5	110 55	MHz	Range over which both transmit and receive reference clocks on any link may be centered. The figure on top relects TXMODE=1 and the bottom one reflects TXMODE=0.	
FO	Frequency Offset	-100	+100	ppm	TX _{TBC} - RX _{TBC}	
T_L,T_H	Pulse Width, Low / High	4.5	2.5	ns	$\label{eq:local_local_local_local_local} Low is measured from V_{IL}(max) to V_{IL}(max), \\ High is measured from V_{IH}(min) to V_{IH}(min). \\ Min measurement refers to TXMODE=0 and \\ Max measurement refers to TXMODE=1. \\ \end{tabular}$	
DC	TBC and REF duty cycle	40	60	%	Measured at 1.5V.	
T_{RCR} , T_{RCF}	TBC and REF rise and fall time	0.6	1.5	ns	Between V_{IL} (max) and V_{IH} (min).	



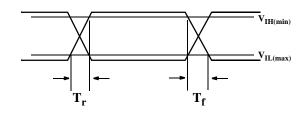
2.125Gb/s Dual Speed, 20-Bit Transceiver

Figure 7: Parametric Measurement Information

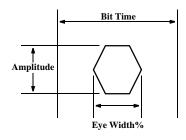
Serial Input Rise and Fall Time



TTL Input and Output Rise and Fall Time

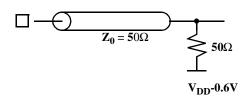


Receiver Input Eye Diagram Jitter Tolerance Mask



Parametric Test Load Circuit

Serial Output Load



TTL AC Output Load





Power Supply Voltage, (V _{DD})	0.5V to +4V
DC Input Voltage (Differential inputs)	0.5V to V _{DD} +0.5V
DC Input Voltage (TTL inputs)	0.5V to V _{DD} +0.5V
DC Output Voltage (TTL Outputs)	-0.5 V to V_{DD} + 0.5 V
Output Current (TTL Outputs)	±50m/
Output Current (Differential Outputs)	±50m/
Case Temperature Under Bias	55°C to +125°C
Storage Temperature	65°C to +150°C
Relative Humidity (Storage)	
Relative Humidity (Operating)	
Maximum Input ESD (Human Body Model)	1500V ⁽²
NOTES: (1) CAUTION: Stresses listed under "Absolute Maximum Ratings" m ing permanent damage. Functionality at or above the values listed is periods may affect device reliability.	
(2) High-speed PECL receiver inputs only are rated at 700V.	
Recommended Operating Conditions	
Power Supply Voltage, (V _{DD})	+3.3V <u>+</u> 5%
Power Supply Noise, (V _{DD})	ייייייייייייייייייייייייייייייייייייי



2.125Gb/s Dual Speed, 20-Bit Transceiver

DC Characteristics (Over recommended operating conditions)

Parameters	Description	Min	Тур	Max	Units	Conditions
V _{OH}	Output HIGH voltage (TTL)	2.4	_	_	V	$I_{OH} = -1.0 \text{ mA}$
V _{OL}	Output LOW voltage (TTL)	_	_	0.5	V	I_{OL} = +1.0 mA
$\Delta { m V}_{ m OUT50}{}^{(1)}$	Serial output absolute voltage differential peak-to-peak swing (TX+/TX-)	600	1100	2000	mV	Driving a 50Ω transmission line (TX+ - TX-)
$\Delta V_{OUT75}^{(1)}$	Serial output absolute voltage differential peak-to-peak swing (TX+/TX-)	600	1100	2000	mV	Driving a 75Ω transmission line (TX+ - TX-)
$\Delta V_{\mathrm{IN}}^{\;\;(1)}$	Serial input absolute voltage differential peak-to-peak swing (RX+/RX-)	400	_	2200	mV	(RX+ - RX-)
V _{IH}	Input HIGH voltage (TTL)	2.0	_	5.5	V	
$V_{ m IL}$	Input LOW voltage (TTL)	0	_	0.8	V	
I _{IH}	Input HIGH current (TTL)	_		1000	μΑ	$V_{IN} = 2.4 \text{ V}$
I_{IL}	Input LOW current (TTL)	_	_	-500	μΑ	$V_{IN} = 0.5 \text{ V}$
V_{DD}	Supply voltage	3.14	_	3.47	V	+3.3V± 5%
P_{D}	Power dissipation	_	2.0	2.5	W	Outputs open, $V_{DD} = V_{DD}$ max
I_{DD}	Supply current	_	550	720	mA	Outputs open, $V_{DD} = V_{DD}$ max
Z _O	Output resistance (TX)	_	50	_	Ω	
Z_{I}	Input resistance (RX)		50		Ω	

NOTE: (1) Refer to Application Note, AN-37, for differential measurement techniques.



2.125Gb/s Dual Speed, 20-Bit Transceiver

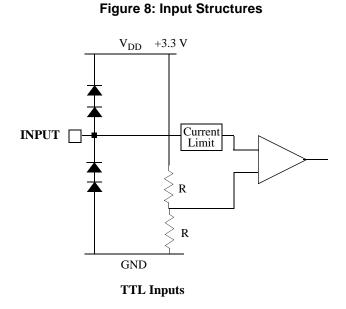
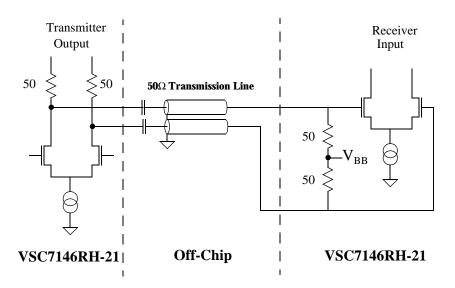
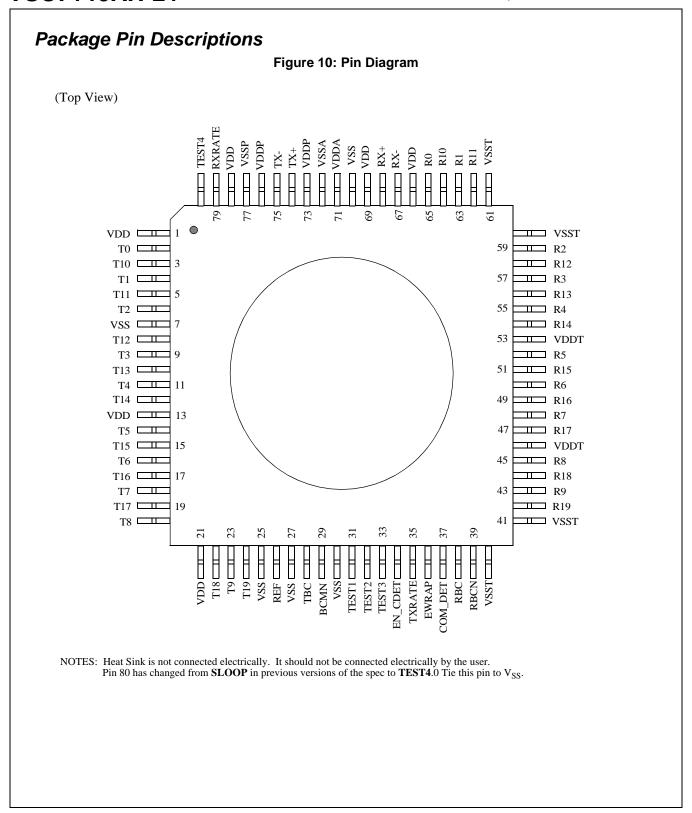


Figure 9: High-Speed I/O Termination Scheme



No external resistor terminations are necessary on the high-speed I/O







2.125Gb/s Dual Speed, 20-Bit Transceiver

Table 6: Pin Identifications

Pin #	Name	Description
2, 4, 6, 9, 11, 14, 16, 18, 20, 23, 3, 5, 8, 10, 12, 15, 17, 19, 22, 24	T[0:19]	INPUTS - TTL: Transmit Data Bus, Bit 0 through Bit 19. 20-bit Transmit Character. Parallel data on this bus is clocked in on the rising edge of TBC. The data bit corresponding to T0 is transmitted first.
26	REF	INPUT - TTL: Reference Clock. REF goes to the PLL/CMU circuitry and is multiplied 20 times.
28	TBC	INPUT - TTL: Transmit Byte Clock. This rising edge of this clock latches T[0:19] into the input register and provides the reference clock at 1/20th of the baud rate to the PLL.
74,75	TX+, TX-	OUTPUTS - Differential (AC-coupling recommended): Transmitter Serial Outputs. These pins output the serialized transmit data when EWRAP is LOW. When EWRAP is HIGH, TX+ is HIGH and TX- is LOW.
65, 63, 59, 57, 55, 52, 50, 48, 45, 43, 64, 62, 58, 56, 54, 51, 49, 47, 44, 42	R[0:19]	OUTPUTS - TTL: Receive Data Bus, Bits 0 thru 19. 20-bit received character. Parallel data on this bus can be sampled on the rising edge of RBC. R0 is the first bit received on RX+/RX
35	TXRATE	INPUT - TTL: Transmitter Dual Rate Selector. LOW for half-speed operation (1Gb/s). HIGH for full-speed operation (2Gbps).
79	RXRATE	INPUT - TTL: Receiver Dual Rate Selector. LOW for half-speed operation (1Gb/s). HIGH for full speed operation (2Gb/s).
29	BCMN	INPUT - TTL: Backwards Compatibility Mode Selector. LOW to allow operation in previous version compatibility (no separate rate controls for transmitter and receiver). HIGH to allow operation with separate rate controls for transmitter and receiver.
36	EWRAP	INPUT - TTL: Enable Internal WRAP Mode. LOW for Normal Operation. When HIGH, an intern loopback path from the transmitter to the receiver is enabled, TX+ = HIGH and TX is LOW.
68, 67	RX+, RX-	INPUTS - Differential (AC-coupling recommended): Receive Serial Inputs. The receiver inputs when EWRAP is LOW.
38, 39	RBC, RBCN	OUTPUT - TTL: Recovered Byte Clock. Recovered clock and complement derived from 1/20 th of th RX+/- data rate. The rising edge of RBC corresponds to a new word on R[0:19].
34	EN_CDET	INPUT - TTL: ENable Comma DETect. Enables COM_DET and word resynchronization when HIGH. When LOW, keeps current word alignment and disables COM_DET.
37	COM_DET	OUTPUT - TTL: COMma DETect. This output goes HIGH to indicate that R[0:6] contains a "comma character ('0011111'). COM_DET can be sampled on the rising edge of RBC.



Pin #	Name	Description
31, 32, 33	TEST1, TEST2, TEST3	TEST Pins For internal Vitesse use only. Customers should tie TEST1, TEST2 and TEST3 to $V_{DD}. \\$
80	TEST4	TEST Pins For internal Vitesse use only. Customers should tie TEST4 to V_{SS} .
1, 13,21, 66, 69,78	VDD	Digital Power Supply, +3.3V.
46, 53	VDDT	TTL Power Supply, +3.3V.
71	VDDA	Analog Power Supply, +3.3V.
73, 76	VDDP	High-Speed Output Driver Power Supply, +3.3V
7, 25, 27, 30, 70	VSS	Digital Ground, 0V.
40, 41, 60, 61	VSST	TTL Ground, 0V.
72	VSSA	Analog Ground, 0V.
77	VSSP	High-Speed Output Driver Ground, 0V.



2.125Gb/s Dual Speed, 20-Bit Transceiver

Package Information G Item 14 mm Tolerance 2.35 MAX Α 2.00 +0.10/-0.05 D Е 0.30 $\pm .05$ F 17.20 ±.25 G 14.00 ±.10 Η 17.20 $\pm .25$ Ι 14.00 $\pm .10$ J 0.88 +.15/-.10 K **BASIC** 0.65 EXPOSED HEATSINK 6.85 ± .50 DIA HEATSINK INTRUSION .0127 MAX 10° TY P 020 PAID, TYP. STÄNDOFF 0.25 MAX. 0.402 MAX LEAD COPLANARITY Drawing not to scale. All units in mm unless otherwise noted.



2.125Gb/s Dual Speed, 20-Bit Transceiver

Package Thermal Characteristics

The VSC7146RH-21 is packaged in an 80-pin, 14mm thermally-enhanced EDQUAD with an internal heat spreader. These packages use industry-standard EIAJ footprints, which have been enhanced to improve thermal dissipation. The construction of the packages are as shown in Figure 11. The VSC7146RH-21 is designed to operate with a case temperature up to 90°C. The user must guarantee that the temperature specification is not violated.

Figure 11: Package Cross Section

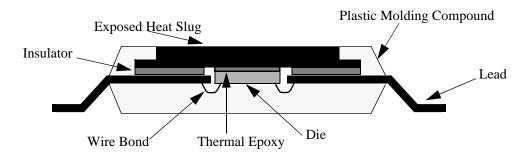


Table 7: Thermal Resistance

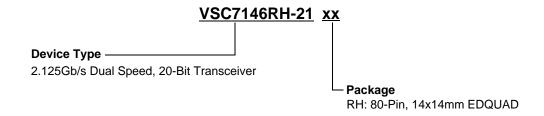
Symbol	Description	Value	Units
$\theta_{ m jc}$	Thermal resistance from junction-to-case	2.5	°C/W
$\theta_{\text{ca-0}}$	Thermal resistance from case-to-ambient, still air	35	°C/W
$\theta_{\text{ca-100}}$	Thermal resistance from case-to-ambient, 100 LFPM air	29	°C/W
$\theta_{\text{ca-200}}$	Thermal resistance from case-to-ambient, 200 LFPM air	26	°C/W
$\theta_{\text{ca-400}}$	Thermal resistance from case-to-ambient, 400 LFPM air	22	°C/W
θ _{ca-600}	Thermal resistance from case-to-ambient, 600 LFPM air	19	°C/W



2.125Gb/s Dual Speed, 20-Bit Transceiver

Ordering Information

The part number for this product is formed by a combination of the device number and the package style:



Notice

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